



## LOW-VOLTAGE QUAD 2:1MUX/DEMUX BUS SWITCH

**IDT74CBTLV3257**

### FEATURES:

- Functionally equivalent to QS3257
- $5\Omega$  Switch Connection between Two Ports
- Isolation Under Power-Off Conditions
- Over-voltage tolerant
- Latch-up performance exceeds 100ma
- $V_{CC} = 2.3V - 3.6V$ , normal range
- ESD > 2000V per MIL-STD-883, Method 3015;  
> 200V using machine model (C = 200pF, R = 0)
- Available in SSOP, QSOP, and TSSOP packages

### APPLICATIONS:

- 3.3V High Speed Bus Switching, Multiplexing, and Bus Isolation

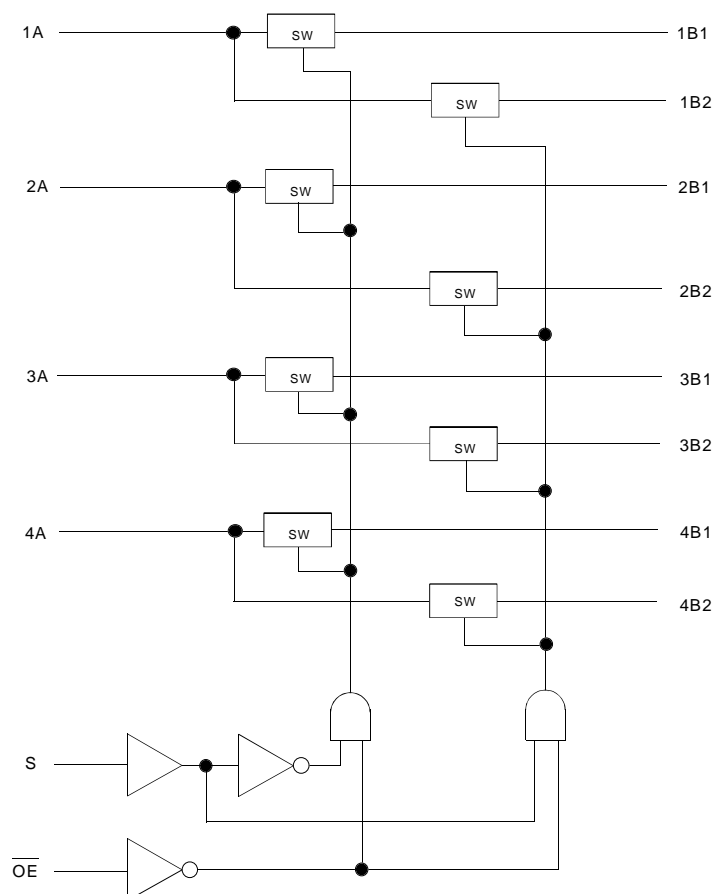
### DESCRIPTION:

The CBTLV3257 is a quad 2:1 multiplexer/demultiplexer. The low on-state resistance of the switch allows connections to be made with minimal propagation delay.

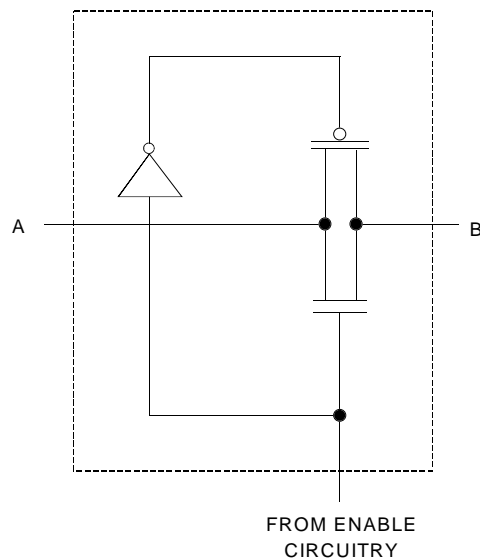
The select (S) input controls the data flow. The multiplexers/demultiplexers are enabled when the output-enable ( $\overline{OE}$ ) input is low.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

### FUNCTIONAL BLOCK DIAGRAM



### SIMPLIFIED SCHEMATIC, EACH SWITCH

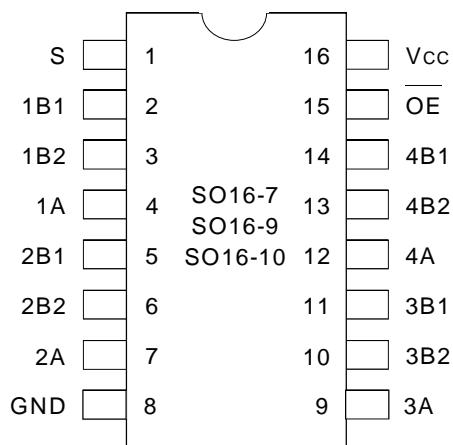


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**INDUSTRIAL TEMPERATURE RANGE**

**SEPTEMBER 2001**

## PIN CONFIGURATION



QSOP/ SSOP/ TSSOP  
TOP VIEW

## ABSOLUTE MAXIMUM RATINGS (1)

Symbol	Description	Max.	Unit
V <sub>CC</sub>	Supply Voltage Range	−0.5 to 4.6	V
V <sub>I</sub>	Input Voltage Range	−0.5 to 4.6	V
	Continuous Channel Current	128	mA
I <sub>IK</sub>	Input Clamp Current, V <sub>I/O</sub> < 0	−50	mA
T <sub>STG</sub>	Storage Temperature	−65 to +150	°C

### NOTES:

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

## FUNCTION TABLE (1)

Inputs		Function
OE	S	
L	L	A Port = B1 Port
L	H	A Port = B2 Port
H	X	Disconnect

### NOTE:

- H = HIGH Voltage Level  
L = LOW Voltage Level  
X = Don't Care

## OPERATING CHARACTERISTICS, T<sub>A</sub> = 25°C

Symbol	Parameter	Test Conditions	Min.	Max.	Unit
V <sub>CC</sub>	Supply Voltage		2.3	3.6	V
V <sub>IH</sub>	High-Level Control Input Voltage	V <sub>CC</sub> = 2.3V to 2.7V	1.7	—	V
		V <sub>CC</sub> = 2.7V to 3.6V	2	—	
V <sub>IL</sub>	Low-Level Control Input Voltage	V <sub>CC</sub> = 2.3V to 2.7V	—	0.7	V
		V <sub>CC</sub> = 2.7V to 3.6V	—	0.8	
T <sub>A</sub>	Operating Free-Air Temperature		−40	+85	°C

### NOTE:

- All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper operation.

## DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Following Conditions Apply Unless Otherwise Specified:

Operating Condition:  $T_A = -40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$

Symbol	Parameter	Test Conditions		Min.	Typ. <sup>(1)</sup>	Max.	Unit
$V_{IK}$	Control Inputs, Data I/O	$V_{CC} = 3\text{V}$ , $I_I = -18\text{mA}$		—	—	-1.2	V
$I_I$	Control Inputs, Data I/O	$V_{CC} = 3.6\text{V}$ , $V_I = V_{CC}$ or GND		—	—	$\pm 1$	$\mu\text{A}$
$I_{OZ}$	Data I/O	$V_{CC} = 3.6\text{V}$ , $V_O = 0$ or $3.6\text{V}$ , switch disabled		—	—	20	$\mu\text{A}$
$I_{OFF}$		$V_{CC} = 0$ , $V_I$ or $V_O = 0$ to $3.6\text{V}$		—	—	50	$\mu\text{A}$
$I_{CC}$		$V_{CC} = 3.6\text{V}$ , $I_O = 0$ , $V_I = V_{CC}$ or GND		—	—	10	$\mu\text{A}$
$\Delta I_{CC}^{(2)}$	Control Inputs	$V_{CC} = 3.6\text{V}$ , One input at $3\text{V}$ , Other inputs at $V_{CC}$ or GND		—	—	300	$\mu\text{A}$
$C_I$	Control Inputs	$V_I = 3\text{V}$ or $0$		—	4	—	pF
$C_{IO(OFF)}$	A port	$V_O = 3\text{V}$ or $0$ , $\overline{OE} = V_{CC} = 3.3\text{V}$		—	13	—	pF
	B port			—	6	—	
$R_{ON}^{(3)}$	Max at $V_{CC} = 2.3\text{V}$ Typ at $V_{CC} = 2.5\text{V}$	$V_I = 0$	$I_O = 64\text{mA}$	—	5	8	$\Omega$
			$I_O = 24\text{mA}$	—	5	8	
	$V_{CC} = 3\text{V}$	$V_I = 1.7\text{V}$	$I_O = 15\text{mA}$	—	27	40	
			$I_O = 64\text{mA}$	—	5	7	
		$V_I = 2.4\text{V}$	$I_O = 24\text{mA}$	—	5	7	
			$I_O = 15\text{mA}$	—	10	15	

### NOTES:

1. Typical values are at  $V_{CC} = 3.3\text{V}$ ,  $+25^{\circ}\text{C}$  ambient.
2. The increase in supply current is attributable to each input that is at the specified voltage level rather than  $V_{CC}$  or GND.
3. This is measured by the voltage drop between the A and B terminals at the indicated current through the switch. On-state resistance is determined by the lower of the voltages of the two (A or B) terminals.

## SWITCHING CHARACTERISTICS

Symbol	Parameter	$V_{CC} = 2.5\text{V} \pm 0.2\text{V}$		$V_{CC} = 3.3\text{V} \pm 0.3\text{V}$		Unit
		Min.	Max.	Min.	Max.	
$t_{PD}^{(1)}$	Propagation Delay A to B or B to A	—	0.15	—	0.25	ns
$t_{SEL}$	Select Time S to A or B	1	6.1	1	5.3	ns
$t_{EN}$	Enable Time S to B	1	6.1	1	5.3	ns
$t_{DIS}$	Disable Time S to B	1	4.8	1	4.5	ns
$t_{EN}$	Enable Time $\overline{OE}$ to A or B	1	5.6	1	5	ns
$t_{DIS}$	Disable Time $\overline{OE}$ to A or B	1	5.5	1	5.5	ns

### NOTE:

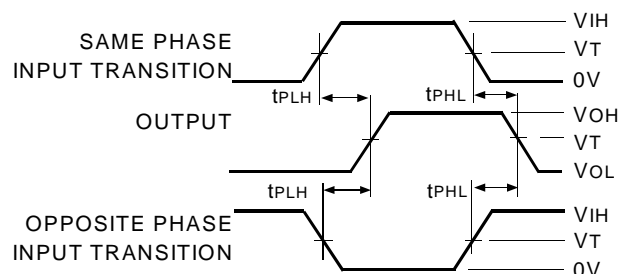
1. The propagation delay is the calculated RC time constant of the typical on-state resistance of the switch and the specified load capacitance when driven by an ideal voltage source (zero output impedance).

## TEST CIRCUITS AND WAVEFORMS

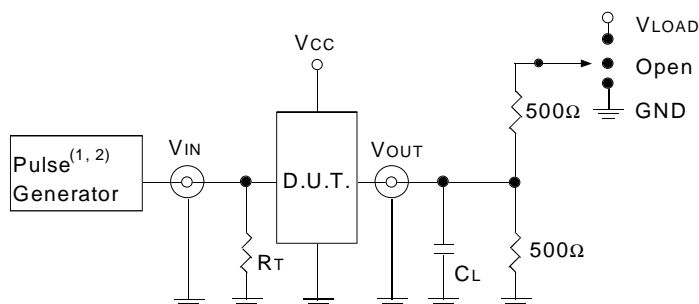
### TEST CONDITIONS

Symbol	$V_{CC}^{(1)} = 3.3V \pm 0.3V$	$V_{CC}^{(2)} = 2.5V \pm 0.2V$	Unit
$V_{LOAD}$	6	$2 \times V_{CC}$	V
$V_{IH}$	3	$V_{CC}$	V
$V_T$	1.5	$V_{CC}/2$	V
$V_{LZ}$	300	150	mV
$V_{HZ}$	300	150	mV
$C_L$	50	30	pF

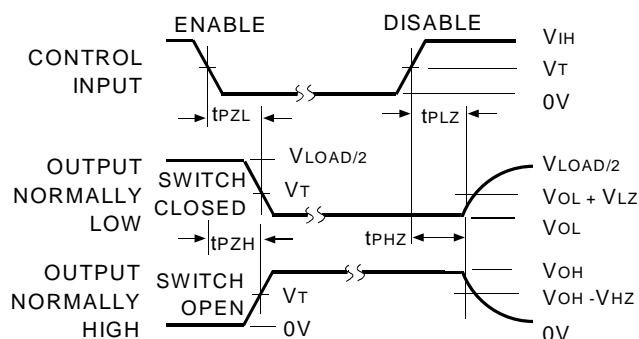
### PROPAGATION DELAY/ SELECT TIME



### TEST CIRCUITS FOR ALL OUTPUTS



### ENABLE AND DISABLE TIMES



#### DEFINITIONS:

$C_L$  = Load capacitance: includes jig and load capacitance.  
 $R_T$  = Termination resistance: should be equal to  $Z_{OUT}$  of the pulse generator.

#### NOTES:

1. Pulse Generator for all pulses: Rate  $\leq 10\text{MHz}$ ;  $t_F \leq 2.5\text{ns}$ ;  $t_R \leq 2.5\text{ns}$
2. Pulse Generator for all pulses: Rate  $\leq 10\text{MHz}$ ;  $t_F \leq 2\text{ns}$ ;  $t_R \leq 2\text{ns}$

#### NOTE:

1. Diagram shown for Input Control Enable-LOW and Input Control Disable-HIGH.

### SWITCH POSITION

Test	Switch
$t_{PLZ}/t_{PZL}$	$V_{LOAD}$
$t_{PHZ}/t_{PZH}$	GND
$t_{PD}$	Open
$t_{SEL}$	Open

## ORDERING INFORMATION

IDT	XX	CBTLV	XXX	XX	
Temp. Range			Device Type	Package	
				Q	Quarter-Size Small Outline Package (SO16-7)
				PY	Shrink Small Outline Package (SO16-9)
				PG	Thin Shrink Small Outline Package (SO16-10)
				3257	Low-Voltage Quad 2:1 Mux/Demux Bus Switch
				74	−40°C to +85°C



**CORPORATE HEADQUARTERS**  
 2975 Stender Way  
 Santa Clara, CA 95054

**for SALES:**  
 800-345-7015 or 408-727-6116  
 fax: 408-492-8674  
[www.idt.com](http://www.idt.com)

**for Tech Support:**  
[logichelp@idt.com](mailto:logichelp@idt.com)  
 (408) 654-6459